

LMV751

Low Noise, Low Vos, Single Op Amp

General Description

The LMV751 is a high performance CMOS operational amplifier intended for applications requiring low noise and low input offset voltage. It offers modest bandwidth of 4.5MHz for very low supply current and is unity gain stable.

The output stage is able to drive high capacitance, up to 1000pF and source or sink 8mA output current.

It is supplied in the space saving SOT23-5 Tiny package.

The LMV751 is designed to meet the demands of small size, low power, and high performance required by cellular phones and similar battery operated portable electronics.

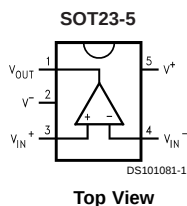
Features

- Low Noise 6.5nV Rt-Hz typ.
- Low Vos (0.05mV typ.)
- Wideband 4.5MHz GBP typ.
- Low Supply Current 500uA typ.
- Low Supply Voltage 2.7V to 5.0V
- Ground-referenced Inputs
- Unity gain stable
- Small Package

Applications

- Cellular Phones
- Portable Equipment
- Radio Systems

Connection Diagrams



Ordering Information

Package	Ordering Info	NSC Drawing	Pkg Marking	Supplied As
5-Pin SOT23-5	LMV751M5	MA05B	A32A	1k Units Tape and Reel
	LMV751M5X	MA05B	A32A	3k units Tape and Reel

Absolute Maximum Ratings (Note 1)

If Military/Aerospace specified devices are required, please contact the National Semiconductor Sales Office/ Distributors for availability and specifications.

ESD tolerance (Note 3)

Human Body Model

2000V

Machine Model

200V

Differential Input Voltage

$\pm$ Supply Voltage

Supply Voltage ($V^+ - V^-$)

5.5V

Lead Temperature (Soldering, 10 sec)

260°C

Storage Temperature Range

-65°C to 150°C

Junction Temperature (T_J) (Note 4)

150°C

Recommended Operating Conditions

Supply Voltage

2.7V to 5.0V

Temperature Range

-40°C $\leq T_J \leq$ 85°C

Thermal resistance (θ_{JA}) (Note 6)

M5 Package, SOT23-5

274°C/W

2.7V Electrical Characteristics

$V^+ = 2.7V$, $V^- = 0V$, $V_{CM} = 1.35V$, $T_A = 25^\circ C$ unless otherwise stated. **Boldface limits** apply over the Temperature Range.

Symbol	Parameter	Condition	Typ (Note 5)	Limit (Note 2)	Units
V_{OS}	Input Offset Voltage		0.05	1.0 1.5	mV max
CMRR	Common Mode Rejection Ratio	$0V < V_{CM} < 1.3V$	100	85 70	dB min
PSRR	Power Supply Rejection Ratio	$V^+ = 2.7V$ to 5.0V	107	85 70	dB min
I_S	Supply Current		0.5	0.7 0.75	mA max
I_{IN}	Input Current		1.5	100	pA max
I_{OS}	Input Offset Current		0.2		pA
A_{VOL}	Voltage Gain	$R_L = 10k$ Connect to $V^+/2$ $V_O = 0.2V$ to 2.2V	120	110 95	dB min
		$R_L = 2k$ Connect to $V^+/2$ $V_O = 0.2V$ to 2.2V	120	100 85	
V_O	Positive Voltage Swing	$R_L = 10k$ Connect to $V^+/2$	2.62	2.54 2.52	V min
		$R_L = 2k$ Connect to $V^+/2$	2.62	2.54 2.52	
V_O	Negative Voltage Swing	$R_L = 10k$ Connect to $V^+/2$	78	140 160	mV max
		$R_L = 2k$ Connect to $V^+/2$	78	140 160	
I_O	Output Current	Sourcing, $V_O = 0V$ $V_{IN}(diff) = \pm 0.5V$	12	6.0 1.5	mA min
		Sinking, $V_O = 2.7V$ $V_{IN}(diff) = \pm 0.5V$	11	6.0 1.5	
e_n (10Hz)	Input Referred Voltage Noise		15.5		$nV/\sqrt{Hz}$
e_n (1kHz)	Input Referred Voltage Noise		7		$nV/\sqrt{Hz}$
e_n (30kHz)	Input Referred Voltage Noise		7	10	$nV/\sqrt{Hz}$ max
$I_N(1kHz)$	Input Referred Current Noise		0.01		$pA/\sqrt{Hz}$
GBW	Gain-Bandwidth Product		4.5	2	MHz min
SR	Slew Rate		2		V/ μs

5.0V Electrical Characteristics

$V^+ = 5.0V$, $V^- = 0V$, $V_{CM} = 2.5V$, $T_A = 25^\circ C$ unless otherwise stated. **Boldface limits** apply over the Temperature Range.

Symbol	Parameter		Typ (Note 5)	Limit (Note 2)	Units
V_{OS}	Input Offset Voltage		0.05	1.0 1.5	mV max
CMRR	Common Mode Rejection Ratio	$0V < V_{CM} < 3.6V$	103	85 70	dB min
PSRR	Power Supply Rejection Ratio	$V^+ = 2.7V$ to $5.0V$	107	85 70	dB min
I_S	Supply Current		0.6	0.8 0.85	mA max
I_{IN}	Input Current		1.5	100	pA max
I_{OS}	Input offset Current		0.2		pA
A_{VOL}	Voltage Gain	$R_L = 10k$ Connect to $V^+/2$ $V_O = 0.2V$ to $4.5V$	120	110 95	dB min
		$R_L = 2k$ Connect to $V^+/2$ $V_O = 0.2V$ to $4.5V$	120	100 85	
V_O	Positive Voltage Swing	$R_L = 10k$ Connect to $V^+/2$	4.89	4.82 4.80	V min
		$R_L = 2k$ Connect to $V^+/2$	4.89	4.82 4.80	
V_O	Negative Voltage Swing	$R_L = 10k$ Connect to $V^+/2$	86	160 180	mV max
		$R_L = 2k$ Connect to $V^+/2$	86	160 180	
I_O	Output Current	Sourcing, $V_O = 0V$ $V_{IN} (diff) = \pm 0.5V$	15	8.0 2.5	mA min
		Sinking, $V_O = 5V$ $V_{IN} (diff) = \pm 0.5V$	20	8.0 2.5	
e_n (10Hz)	Input Referred Voltage Noise		15		$nV/\sqrt{Hz}$
e_n (1kHz)	Input Referred Voltage Noise		6.5		$nV/\sqrt{Hz}$
e_n (30kHz)	Input Referred Voltage Noise		6.5	10	$nV/\sqrt{Hz}$ max
I_N (1kHz)	Input Referred Current Noise		0.01		$pA/\sqrt{Hz}$
GBW	Gain-Bandwidth Product		5	2	MHz min
SR	Slew Rate		2.3		V/ μs

Note 1: Absolute Maximum Ratings indicate limits beyond which damage to the device may occur. Electrical specifications do not apply when operating the device beyond its rated operating conditions.

Note 2: All limits are guaranteed by testing or statistical analysis

Note 3: Human body model, $1.5k\Omega$ in series with $100pF$. Machine model, 200Ω in series with $1000pF$.

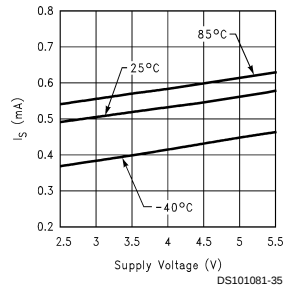
Note 4: The maximum power dissipation is a function of $T_J(max)$, θ_{JA} , and T_A . The maximum allowable power dissipation at any ambient temperature is $P_D = (T_J(max) - T_A)/\theta_{JA}$. All numbers apply for packages soldered directly into a PC board.

Note 5: Typical values represent the most likely parametric norm.

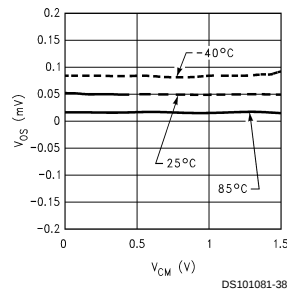
Note 6: All numbers are typical, and apply to packages soldered directly onto PC board in still air.

Typical Performance Characteristics

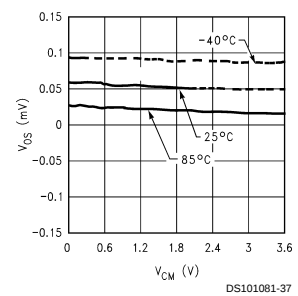
Supply Current vs. Voltage



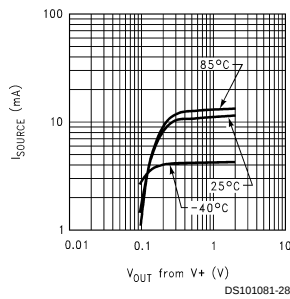
**V_{OS} vs. V_{CM}
 $V^+ = 2.7V$**



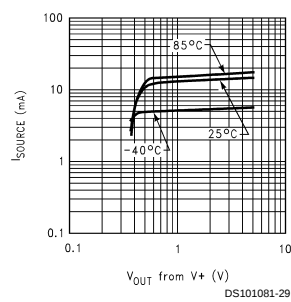
**V_{OS} vs. V_{CM}
 $V^+ = 5.0V$**



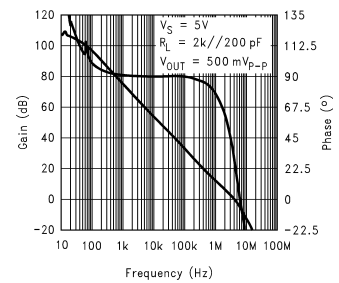
**Source Current vs. Out
 $V^+ = 2.7V$**



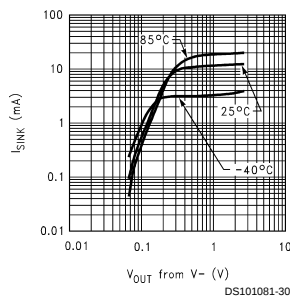
**Source Current vs. V_{OUT}
 $V^+ = 5.0V$**



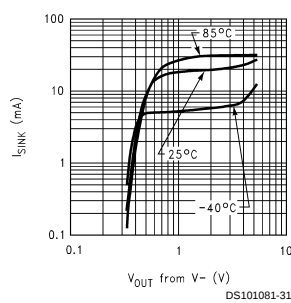
Gain/Phase



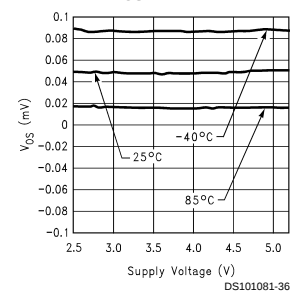
**Sinking Current vs. V_{OUT}
 $V^+ = 2.7V$**



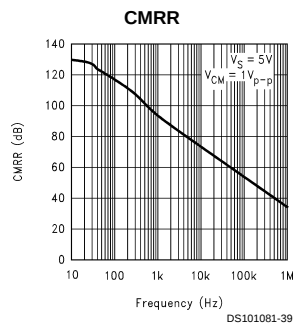
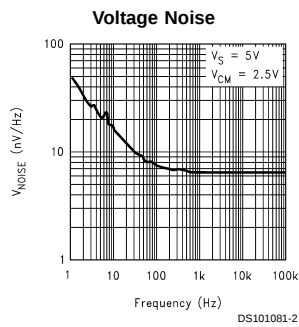
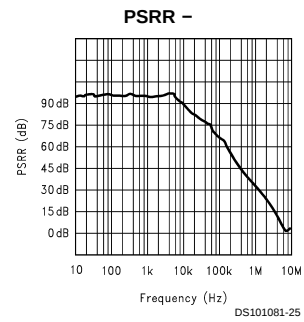
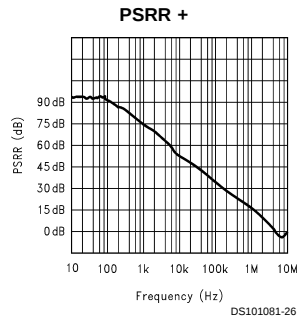
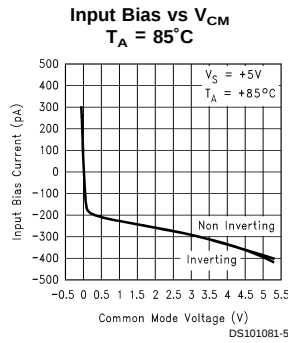
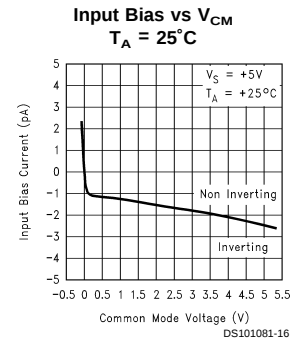
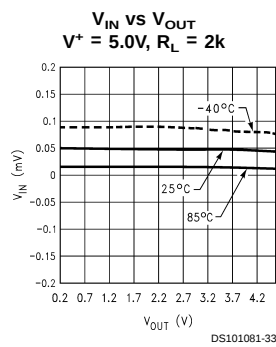
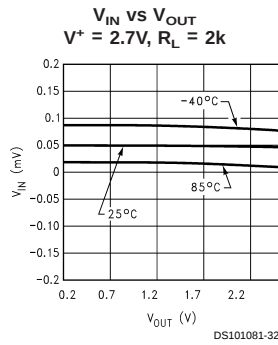
**Sinking Current vs. V_{OUT}
 $V^+ = 5.0V$**



V_{OS} vs. V^+



Typical Performance Characteristics (Continued)



Application Hints

1.0 Noise

There are many sources of noise in a system: thermal noise, shot noise, 1/f, popcorn noise, resistor noise, just to name a few. In addition to starting with a low noise op amp, such as the LMV751, careful attention to detail will result in the lowest overall noise for the system.

1.1 To invert or not invert?

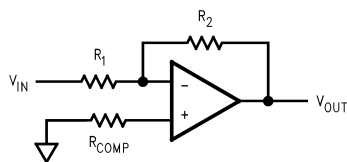
Both inverting and non-inverting amplifiers employ feedback to stabilize the closed loop gain of the block being designed. The loop gain (in decibels) equals the algebraic difference between the open loop and closed loop gains. Feedback improves the Total Harmonic Distortion (THD) and the output impedance. The various noise sources, when input referred, are amplified, not by the closed loop gain, but by the noise gain. For a non-inverting amplifier, the noise gain is equal to the closed loop gain, but for an inverting amplifier, the noise gain is equal to the closed loop gain plus one. For large gains, e.g., 100, the difference is negligible, but for small gains, such as one, the noise gain for the inverting amplifier would be two. This implies that non-inverting blocks are preferred at low gains.

1.2 Source impedance

Because noise sources are uncorrelated, the system noise is calculated by taking the RMS sum of the various noise sources, that is, the square root of the sum of the squares. At very low source impedances, the voltage noise will dominate; at very high source impedances, the input noise current times the equivalent external resistance will dominate. For a detailed example calculation, refer to Note 1.

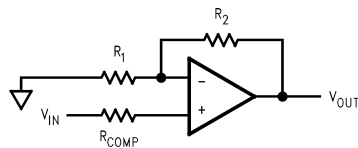
1.3 Bias current compensation resistor

In CMOS input op amps, the input bias currents are very low, so there is no need to use R_{COMP} (Figure 1 and 2) for bias current compensation that would normally be used with early generation bipolar op amps. In fact, inclusion of the resistor would act as another thermal noise source in the system, increasing the overall noise.



DS101081-23

Figure 1



DS101081-24

Figure 2

1.4 Resistor types

Thermal noise is generated by any passive resistive element. This noise is "white"; meaning it has a constant spectral density. Thermal noise can be represented by a mean-square voltage generator e_R^2 in series with a noiseless resistor, where e_R^2 is given by: Where:

$$e_R^2 = 4K TRB \text{ (volts)}^2$$

Where T = temperature in °K

R = resistor value in ohms

B = noise bandwidth in Hz

K = Boltzmann's constant ($1.38 \times 10^{-23} \text{ W-sec/}^\circ\text{K}$)

Actual resistor noise measurements may have more noise than the calculated value. This additional noise component is known as excess noise. Excess noise has a 1/f spectral response, and is proportional to the voltage drop across the resistor. It is convenient to define a noise index when referring to excess noise in resistors. The noise index is the RMS value in μV of noise in the resistor per volt of DC drop across the resistor in a decade of frequency. Noise index expressed in dB is:

$$NI = 20 \log ((E_{EX}/V_{DC}) \times 10^6) \text{ db}$$

Where: E_{EX} = resistor excess noise in μV per frequency decade.

V_{DC} = DC voltage drop across the resistor.

Excess noise in carbon composition resistors corresponds to a large noise index of +10 dB to -20 dB. Carbon film resistors have a noise index of -10 dB to -25 dB. Metal film and wire wound resistors show the least amount of excess noise, with a noise index figure of -15 dB to -40 dB.

1.5 Other noise sources:

As the op amp and resistor noise sources are decreased, other noise contributors will now be noticeable. Small air currents across thermocouples will result in low frequency variations. Any two dissimilar metals, such as the lead on the IC and the solder and copper foil of the pc board, will form a thermocouple. The source itself may also generate noise. An example would be a resistive bridge. All resistive sources generate thermal noise based on the same equation listed above under "resistor types".(2)

Application Hints (Continued)

1.6 Putting it all together

To a first approximation, the total input referred noise of an op amp is:

$$E_t^2 = e_n^2 + e_{req}^2 + (i_n \cdot R_{eq})^2$$

where R_{eq} is the equivalent source resistance at the inputs. At low impedances, voltage noise dominates. At high impedances, current noise dominates. With a typical noise current on most CMOS input op amps of 0.01 pA/rt-Hz, the current noise contribution will be smaller than the voltage noise for R_{eq} less than one megohm.

2.0 Other Considerations

2.1 Comparator operation

Occasionally operational amplifiers are used as comparators. This is not optimum for the LMV751 for several reasons. First, the LMV751 is compensated for unity gain stability, so the speed will be less than could be obtained on the same process with a circuit specifically designed for comparator operation. Second, op amp output stages are designed to be linear, and will not necessarily meet the logic levels required under all conditions. Lastly, the LMV751 has the newer PNP-NPN common emitter output stage, characteristic of many rail-to-rail output op amps. This means that when used in open loop applications, such as comparators, with very light loads, the output PNP will saturate, with the output current being diverted into the previous stage. As a result, the supply current will increase to the 20-30 mA range. When used as a comparator, a resistive load between 2k Ω and 10k Ω should be used with a small amount of hysteresis to alleviate this problem. When used as an op amp, the closed loop gain will drive the inverting input to within a few millivolts of the non-inverting input. This will automatically reduce the output drive as the output settles to the correct value; thus it is only when used as a comparator that the current will increase to the tens of milliampere range.

2.2 Rail-to-Rail

Because of the output stage discussed above, the LMV751 will swing "rail-to-rail" on the output. This normally means within a few hundred millivolts of each rail with a reasonable load. Referring to the Electrical Characteristics table for 2.7V to 5.0V, it can be seen that this is true for resistive loads of 2k Ω and 10k Ω . The input stage consists of cascoded P-channel MOSFETS, so the input common mode range includes ground, but typically requires 1.2V to 1.3V headroom from the positive rail. This is better than the industry standard LM324 and LM358 that have PNP input stages, and the LMV751 has the advantage of much lower input bias currents.

2.3 Loading

The LMV751 is a low noise, high speed op amp with excellent phase margin and stability. Capacitive loads up to 1000 pF can be handled, but larger capacitive loads should be isolated from the output. The most straightforward way to do this is to put a resistor in series with the output. This resistor will also prevent excess power dissipation if the output is accidentally shorted.

2.4 General Circuits

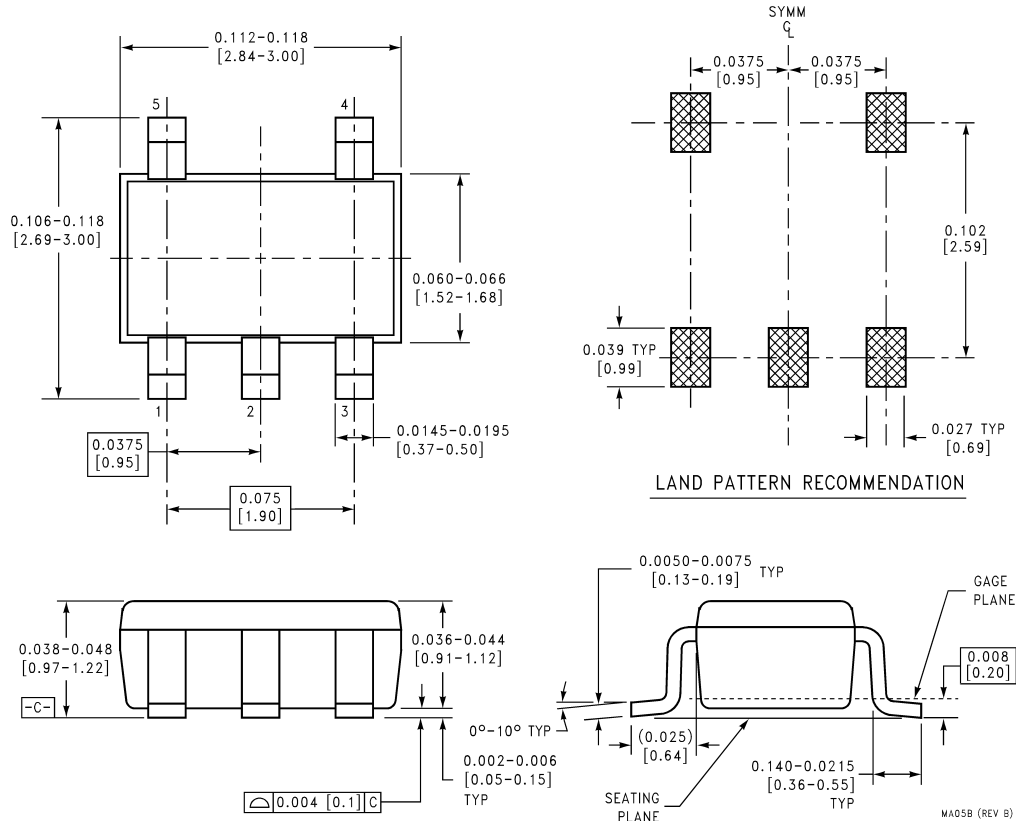
With the low noise and low input bias current, the LMV751 would be useful in active filters, integrators, current to voltage converters, low frequency sine wave generators, and instrumentation amplifiers. (3)

Note: 1. Sherwin, Jim "Noise Specs Confusing?" AN-104, National Semiconductor.

2. Christensen, John, "Noise-figure curve ease the selection of low-noise op amps", EDN, pp 81-84, Aug. 4, 1994

3. "Op Amp Circuit Collection", AN-31, National Semiconductor.

Physical Dimensions inches (millimeters) unless otherwise noted



SOT23-5
Order Number LMV751M5
NS Package Number MA05B

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